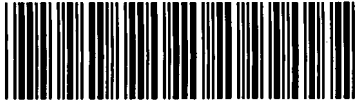


**Search Notes**

Application/Control No.

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Examiner

Dimple N. Bodawala

Applicant(s)/Patent under  
Reexamination

VEARIEL ET AL.

Art Unit

1722

**SEARCHED**

Class	Subclass	Date	Examiner
425	378.1,382 R,382.2	5/15/2007	DB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated previous search	5/15/2007	DB